



Report No.: SZEM210100084403

Page: 1 of 7

RF Exposure Evaluation Report

Application No.: SZEM2101000844CR
Applicant: Hon Lin Technology Co., Ltd.
Address of Applicant: 11F, No.32, Jihu Rd., Neihu Dist., Taipei City 114, Taiwan
Manufacturer: NANNING FUGUI PRECISION INDUSTRIAL CO., LTD.
Address of Manufacturer: No.51, Tongle Avenue, Nanning, Guangxi. China
Factory: NANNING FUGUI PRECISION INDUSTRIAL CO., LTD.
Address of Factory: No.51, Tongle Avenue, Nanning, Guangxi. China
Equipment Under Test (EUT):
EUT Name: Sirius Fly mPro
Model No.: M.2-B048-101
FCC ID: 2AQ68T99B123T03
47 CFR Part 1.1307
Standards: 47 CFR Part 1.1310
47 CFR Part 2.1091
Date of Receipt: 2021-01-20
Date of Test: 2021-01-20 to 2021-02-01
Date of Issue: 2021-02-02

Test Result :	Pass*
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* In the configuration tested, the EUT complied with the standards specified above.

Keny Xu

Keny Xu
EMC Laboratory Manager



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Attention: To check the authenticity of testing / inspection report & certificate, please contact us at telephone: (86-755) 8307 1443, or email: CN.Doccheck@sgs.com

SGS-CSTC Standards Technical Services Co., Ltd.
Shenzhen Branch EMC Laboratory

No.1 Workshop, M-10, Middle Section, Science & Technology Park, Shenzhen, China 518057 t (86-755) 26012053 f (86-755) 26710594 www.sgsgroup.com.cn
中国·深圳·科技园中区M-10栋一号厂房 邮编: 518057 t (86-755) 26012053 f (86-755) 26710594 sgs.china@sgs.com



2 Version

Revision Record				
Version	Chapter	Date	Modifier	Remark
01		2021-02-02		Original

Authorized for issue by:				
				
		Calvin Weng /Project Engineer		
				
		Eric Fu /Reviewer		





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4 General Information

4.1 General Description of EUT

Power supply:	DC3.3V from main board. Main board rated input: DC12V/1A
Sample Type:	Mobile Product
LTE Operation Frequency Band:	48
Frequency range:	3550-3700 MHz
Modulation Type:	UL: QPSK, 16QAM, 64QAM DL: QPSK, 16QAM, 64QAM, 256QAM
LTE Release Version:	R11
LTE Power Class:	Level 3
CA Capability MIMO:	DL 2CC 2X2 MIMO DL 1CC 2X2 MIMO UL 1CC 2X2 MIMO UL 2CC SISO Support Intra-band contiguous/non-contiguous CA and support UL MIMO
Antenna Type:	Dipole Antenna Ant 1: TX & RX Ant 2: TX & RX
Antenna Gain:	2.5dBi
SIM Card:	This device has only one SIM Card sockets.
Remark: The EUT is a M.2 Module.	



4.2 Test Location

All tests were performed at:

SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch

No. 1 Workshop, M-10, Middle section, Science & Technology Park, Shenzhen, Guangdong, China 518057

Telephone: +86 (0) 755 2601 2053 Fax: +86 (0) 755 2671 0594

No tests were sub-contracted.

4.3 Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

- **A2LA (Certificate No. 3816.01)**

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen EMC Laboratory is accredited by the American Association for Laboratory Accreditation(A2LA). Certificate No. 3816.01.

- **VCCI**

The 3m Fully-anechoic chamber for above 1GHz, 10m Semi-anechoic chamber for below 1GHz, Shielded Room for Mains Port Conducted Interference Measurement and Telecommunication Port Conducted Interference Measurement of SGS-CSTC Standards Technical Services Co., Ltd. have been registered in accordance with the Regulations for Voluntary Control Measures with Registration No.: G-20026, R-14188, C-12383 and T-11153 respectively.

- **FCC –Designation Number: CN1178**

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen EMC Laboratory has been recognized as an accredited testing laboratory.

Designation Number: CN1178. Test Firm Registration Number: 406779.

- **Innovation, Science and Economic Development Canada**

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen EMC Laboratory has been recognized by ISED as an accredited testing laboratory.

CAB identifier: CN0006.

IC#: 4620C.

4.4 Deviation from Standards

None.

4.5 Abnormalities from Standard Conditions

None.

4.6 Other Information Requested by the Customer

None.



5 RF Exposure Evaluation

5.1 RF Exposure Compliance Requirement

5.1.1 Limits

According to FCC Part1.1310: The criteria listed in the following table shall be used to evaluate the environment impact of human exposure to radio frequency (RF) radiation as specified in part1.1307(b)

TABLE 1—LIMITS FOR MAXIMUM PERMISSIBLE EXPOSURE (MPE)

Frequency range (MHz)	Electric field strength (V/m)	Magnetic field strength (A/m)	Power density (mW/cm ²)	Averaging time (minutes)
(A) Limits for Occupational/Controlled Exposures				
0.3–3.0	614	1.63	*(100)	6
3.0–30	1842/f	4.89/f	*(900/f ²)	6
30–300	61.4	0.163	1.0	6
300–1500			f/300	6
1500–100,000			5	6
(B) Limits for General Population/Uncontrolled Exposure				
0.3–1.34	614	1.63	*(100)	30
1.34–30	824/f	2.19/f	*(180/f ²)	30
30–300	27.5	0.073	0.2	30
300–1500			f/1500	30
1500–100,000			1.0	30

F= Frequency in MHz

Friis Formula

Friis transmission formula: $P_d = (P_{out} * G) / (4 * \pi * R^2)$

Where

P_d = power density in mW/cm²

P_{out} = output power to antenna in mW

G = gain of antenna in linear scale

π = 3.1416

For Uncontrolled Environment, the MPE limit of 1500MHz to 100000MHz is 1.0 mW/cm². If we know the maximum gain of the antenna and the total power input to the antenna, through the calculation, we will know the distance r where the MPE limit is reached.

5.1.2 Test Procedure

Software provided by client enabled the EUT to transmit and receive data at lowest, middle and highest channel individually.





5.1.3 EUT RF Exposure Evaluation

1) Test Results

For LTE Band 48:

The max tune-up tolerance power Into Antenna & RF Exposure Evaluation Distance:

SISO

Antenna	Max Antenna Gain (dBi)	Max Antenna Gain (Numeric)	Max tune-up tolerance power (dBm)	Max tune-up Tolerance power to Antenna (mW)	Power Density at R = 20 cm (mW/cm ²)	Limit (mW/cm ²)	MPE Ratios	Result
Ant1	2.5	1.78	20.5	112.20	0.0397	1.0	0.0397	PASS

MIMO

Antenna	Max Antenna Gain (dBi)	Max Antenna Gain (Numeric)	Max tune-up tolerance power (dBm)	Max tune-up Tolerance power to Antenna (mW)	Power Density at R=20 cm (mW/cm ²)	Limit (mW/cm ²)	MPE Ratios	Result
Ant1+2	2.5	1.78	20.5	112.20	0.0397	1.0	0.0397	PASS

Note: Refer to report No. SZEM210100084402 or EUT test Max Conducted Output Power value.

The distance (6th column) calculated from the Fries transmission formula is far greater than 20 cm separation requirement.

Since the SAR Exclusion Threshold Level is well below the SAR low threshold level, so the EUT is considered to comply with SAR requirement without testing.

- End of the Report -

